



SBAS070B - OCTOBER 1995 - REVISED AUGUST 2002

10-Bit, 60MHz Sampling ANALOG-TO-DIGITAL CONVERTER

FEATURES

- HIGH SNR: 60dB
- HIGH SFDR: 74dBFS
- LOW POWER: 265mW
- INTERNAL/EXTERNAL REFERENCE OPTION
- SINGLE-ENDED OR DIFFERENTIAL ANALOG INPUT
- PROGRAMMABLE INPUT RANGE
- LOW DNL: 0.25LSB
- SINGLE +5V SUPPLY OPERATION

DESCRIPTION

The ADS823 and ADS826 are pipeline, CMOS Analog-to-Digital Converters (ADCs) that operate from a single +5V power supply. These converters provide excellent performance with a single-ended input and can be operated with a differential input for added spurious performance. These high-performance converters include a 10-bit quantizer, highbandwidth track-and-hold, and a high-accuracy internal reference. They also allow for disabling the internal reference and utilizing external references. This external reference option provides excellent gain and offset matching when used in multi-channel applications or in applications where full-scale range adjustment is required.

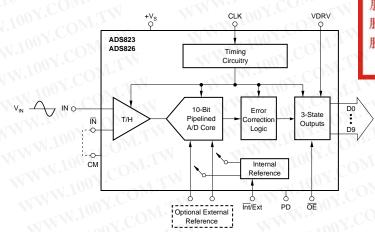
- +3V/+5V LOGIC I/O COMPATIBLE (ADS826)
- POWER DOWN: 20mW
- SSOP-28 PACKAGE

APPLICATIONS

- MEDICAL IMAGING
- COMMUNICATIONS
- CCD IMAGING
- VIDEO DIGITIZING
- TEST EQUIPMENT

The ADS823 and ADS826 employ digital error correction techniques to provide excellent differential linearity for demanding imaging applications. Their low distortion and high SNR give the extra margin needed for medical imaging, communications, video, and test instrumentation. The ADS823 and ADS826 offer power dissipation of 265mW and also provide a power-down mode, thus reducing power dissipation to only 20mW.

The ADS823 and ADS826 are specified at a maximum sampling frequency of 60MHz and a single-ended input range of 1.5V to 3.5V. The ADS823 and ADS826 are available in an SSOP-28 package and are pin-compatible with the 10-bit, 40MHz ADS822 and ADS825, and the 10-bit, 75MHz ADS828.



勝 特 力 材 料 886-3-5753170 胜特力电子(上海) 86-21-54151736 胜特力电子(深圳) 86-755-83298787 Http://www.100y.com.tw



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



ELECTROSTATIC DISCHARGE SENSITIVITY

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ABSOLUTE MAXIMUM RATINGS(1)

+V _S	+6V
Analog Input	–0.3V to (+V _S + 0.3V)
Logic Input	-0.3V to (+V _S + 0.3V)
Case Temperature	+100°C
Junction Temperature	
Storage Temperature	

NOTE: (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximumrated conditions of extended periods may affect device reliability.

EVALUATION MODULE ORDERING INFORMATION

PRODUCT	EVALUATION MODULE
ADS823E	DEM-ADS823E

PACKAGE/ORDERING INFORMATION

PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR ⁽¹⁾	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER ⁽¹⁾	TRANSPORT MEDIA, QUANTITY
ADS823E	SSOP-28	DB	-40°C to +85°C	ADS823E	ADS823E	Rails
N. I.	CONL		V CONT		ADS823E/1K	Tape and Reel, 1000
ADS826E	SSOP-28	DB	-40°C to +85°C	ADS826E	ADS826E	Rails
WW.LOC	CONTRACT	WWW.L	N.CUMMAN	"	ADS826E/1K	Tape and Reel, 1000

NOTE: (1) Fot the most current specifications and package information, refer to our web site at www.ti.com. (2) Models with a slash (/) are available only in Tape and Reel in the quantities indicated (e.g., /1K indicates 1000 devices per reel). Ordering 1000 pieces of ADS823E/1K" will get a single 1000-piece Tape and Reel.

ELECTRICAL CHARACTERISTICS

At T_A = full specified temperature range, V_S = +5V single-ended input range = 1.5V to 3.5V, sampling rate = 60MHz, external reference, unless otherwise noted.

RESOLUTION ID Tested ID Tested ID Tested Bits SPECIFIED TEMPERATURE RANGE Ambient Air -40 to +85 -40 to +85 -40 to +85 C AMALOG INPUT Standard Single-Ended Input Range 2V(p-p 1.5 3.5 * * V Common-Mode Voltage 0 2.5 3 * V V Common-Mode Voltage 2.5 3 * V V V Common-Mode Voltage 2.5 3 * V V V Optional Differential Input Range 2V(p-p 2 3 * V V Analog Input Bias Current 1 1.25 II 5 3 * W MA M II M Input Impedance -300 * * W MA M II M ME MEZ Sample Rate 10k 60M * * Samples Sample Rate 100k 5 * LSB Differential Linearity Error (largest code error) 1 10.5 12.0 <td< th=""><th>WWW.</th><th></th><th>Yoo.</th><th>ADS823E</th><th>WT</th><th>V</th><th>ADS826E(1)</th><th></th><th>T</th></td<>	WWW.		Yoo.	ADS823E	WT	V	ADS826E(1)		T
SPECIFIED TEMPERATURE RANGE Ambient Air -40 to +85 -40 to +85 -20 ANALOG INPUT 2Vp-p 1.5 3.5 * * V Standard Single-Ended Input Range 2Vp-p 1.5 3.5 * * V Common-Mode Voltage 1Vp.p 2 3 * * V Common-Mode Voltage 2Vp-p 2 3 * * V Optional Differential Input Range 2Vp-p 2 3 * * V Analog Input Bias Current 2Vp-p 2 3 * * V Anolog Input Bias Current 3dBFS Input -300 * * MALQ Dotterential Linearity Error (largest code error) 3dBFS Input 10k 60M * * LSB Differential Linearity Error (largest code error) 1 10k 60M * LSB LSB 1 = 1MHz No Missing Codes 1 10LS 20.25 ±1.0 * LSB	WW.100 1. CO	M.I. T. WY	MIN	ТҮР	MAX	MIN	TYP	MAX	UNITS
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Effective Number of Bits ⁽⁵⁾ , f = 1MHz Input Grounded 9.5 * Bits Dutput Noise Input Grounded 0.2 * LSBs rm Aperture Delay Time 3 * ns Aperture Jitter 1.2 * ps rms Over Voltage Recovery Time ⁽⁵⁾ 2 * ns			56			55			
Dutput Noise Input Grounded 0.2 * LSBs rm Aperture Delay Time 3 * ns Aperture Jitter 1.2 * ps rms Over Voltage Recovery Time ⁽⁵⁾ 2 * ns	-		00		N NAME	00			
Aperture Delay Time 3 * ns Aperture Jitter 1.2 * ps rms Dver Voltage Recovery Time ⁽⁶⁾ 2 * ns	,	Input Grounded	NTN.			1001	•		
Aperture Jitter 1.2 * ps rms Over Voltage Recovery Time ⁽⁵⁾ 2 * ns		input Grounded							
Dver Voltage Recovery Time ⁽⁵⁾			L TY		M.	×1100			
			Nr.	1	MIN	N			
	Full-Scale Step Acquisition Time		T	5	VI.	-10	*		ns

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ELECTRICAL CHARACTERISTICS (Cont.)

At T_A = full specified temperature range, V_S = +5V single-ended input range = 1.5V to 3.5V, sampling rate = 60MHz, external reference, unless otherwise noted.

100 1		W.10	ADS823E		<1.	ADS826E(1)		
WW 100	W WILM	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
DIGITAL INPUTS .ogic Family Convert Command	Start Conversion		OS-Compa				Compatible	
ligh Level Input Current ⁽⁶⁾ (V _{IN} = 5V)	Start Conversion	Rising Ed	ge of Cor	vert Clock	Rising Ed	ge of Con	vert Clock	
				+100			*	μA
ow Level Input Current (V _{IN} = 0V)		10.5		+10	.0.0		*	μA
igh Level Input Voltage		+3.5			+2.0		.0.0	V
ow Level Input Voltage			- 10	+1.0	VT.	×.	+0.8	V pF
nput Capacitance	.10° CONT.		5	-1 C O	Mr.	*		p⊢
IGITAL OUTPUTS				001.	T. M.			
ogic Family		-1	CMOS	T C	DMT.	CMOS	I	
ogic Coding		Straig	ht Offset	Binary	Straig	ght Offset B	Binary	
ow Output Voltage (I _{OL} = 50µA to 1.6mA)	VDRV = 5V	L		+0.1	OM.		*	V
ligh Output Voltage, (I _{OH} = 50µA to 0.5mA)		+4.9		1001.	*			V
ow Output Voltage, (I _{OL} = 50µA to 1.6mA)	VDRV = 3V			+0.1	COM		*	V
igh Output Voltage, (I _{OH} = 50µA to 0.5mA)		+2.8		1001	*	TW		V
-State Enable Time	$\overline{OE} = H$ to L		2	40	T CON	*	*	ns
-State Disable Time	$\overline{OE} = L \text{ to } H$		2	10	1.0	*	*	ns
Output Capacitance		1	5	11.10	$< CO_{1}$	*		pF
CCURACY (Internal Reference, 2Vp-p, Unless Otherwise Noted)	f _S = 2.5Mhz		N4	W.10) <u>, , (</u>	W.	≪ 1	
ero Error (referred to –FS)	At 25°C		±1.0	±3.0	01.0	*	*	% FS
ero Error Drift (referred to –FS)	AI 25 C		±1.0 16	±3.0	- T C	*	*	/% F3
lidscale Offset Error	At 25°C	N N	10		.001.	±0.29		% FS
ain Error ⁽⁷⁾	At 25 C At 25°C		±1.5	±3.5	100	10.29	*	% FS
ain Error Drift ⁽⁷⁾	Al 25°C	WT.	±1.5 66	±3.0	1001.		*	
	At 25°C	1.1		10.5	.10	*		ppm/°0 % FS
	At 25°C	WT .	±1.0	±2.5	1003	*	*	
ain Error Drift ⁽⁸⁾		M	23		N.100	*	1.	ppm/°C
ower-Supply Rejection of Gain	$\Delta V_{\rm S} = \pm 5\%$	177	70		100	*	NT.	dB
EFT Tolerance	Deviation From Ideal 3.5V	N1.1	±10	±25	W.10	*	*	mV
EFB Tolerance ⁽⁹⁾	Deviation From Ideal 1.5V		±10	±25		*	*	mV
xternal REFT Voltage Range		REFB + 0.8	3.5	V _S – 1.25	*	*	*	V
xternal REFB Voltage Range		1.25	1.5	REFT – 0.8	*	*	*	V
eference Input Resistance	REFT to REFB	COM	1.6		TAN N.	*	ON	kΩ
	N SN Loo	4.75			1	1001.		
upply Voltage: +V _S	Operating	+4.75	+5.0	+5.25	*	*	(*)	V
upply Current: +I _S	Operating	Y	55	0.05		*		mA
ower Dissipation: VDRV = 5V	External Reference	-1 CO	275	335		*	- (*)	mW
VDRV = 3V	External Reference	N	265		N.	*	1.	mW
VDRV = 5V	Internal Reference		295	350		*	*	mW
VDRV = 3V	Internal Reference	0Y.	285		N.	*	01.~	mW
Power-Down	Operating		20			*		mW
hermal Resistance, θ_{JA}		.001.4		N.	N.	1	001.~	
SSOP-28		10-	89	- * T		*	-1 C	°C/W

* Indicates the same specifications as the ADS823E.

NOTES: (1) ADS826 accepts a +3V clock input. (2) Spurious-Free Dynamic Range refers to the magnitude of the largest harmonic. (3) dBFS means dB relative to Full-Scale. (4) 2-tone intermodulation distortion is referred to the largest fundamental tone. This number will be 6dB higher if it is referred to the magnitude of the 2-tone fundamental envelope. (5) Effective number of bits (ENOB) is defined by (SINAD – 1.76)/6.02. (6) A 50kΩ pull-down resistor is inserted internally on OE pin. (7) Includes internal reference. (8) Excludes internal reference. (9) Ensured by design.

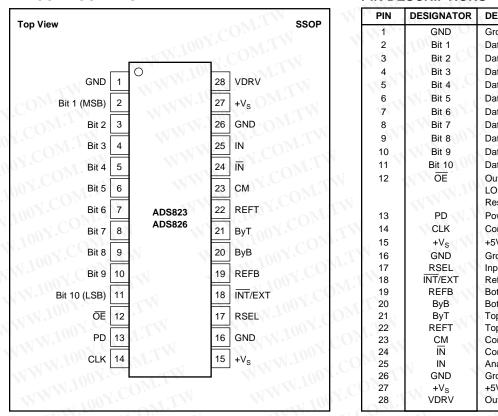
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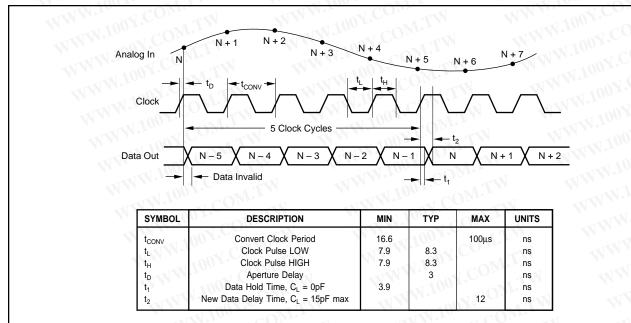
PIN CONFIGURATION



PIN DESCRIPTIONS

DESIGNATOR	DESCRIPTION
GND	Ground
Bit 1	Data Bit 1 (D9) (MSB)
Bit 2	Data Bit 2 (D8)
Bit 3	Data Bit 3 (D7)
Bit 4	Data Bit 4 (D6)
Bit 5	Data Bit 5 (D5)
Bit 6	Data Bit 6 (D4)
Bit 7	Data Bit 7 (D3)
Bit 8	Data Bit 8 (D2)
Bit 9	Data Bit 9 (D1)
Bit 10	Data Bit 10 (D0) (LSB)
OE	Output Enable. HI: High Impedance State.
.W.10	LO: Normal Operation (Internal Pull-Down
NW .	Resistor)
PD	Power Down: HI = Power Down; LO = Normal
CLK	Convert Clock Input
+V _S	+5V Supply
GND	Ground
RSEL	Input Range Select: HI = 2V; LO = 1V
INT/EXT	Reference Select: HI = External; LO = Internal
REFB ByB	Bottom Reference Bottom Ladder Bypass
вув ВуТ	Top Ladder Bypass
REFT	Top Reference
CM	Common-Mode Voltage Output
ĪN	Complementary Input (-)
IN IN	Analog Input (+)
GND	Ground
+V _S	+5V Supply
VDRV	Output Logic Driver Supply Voltage

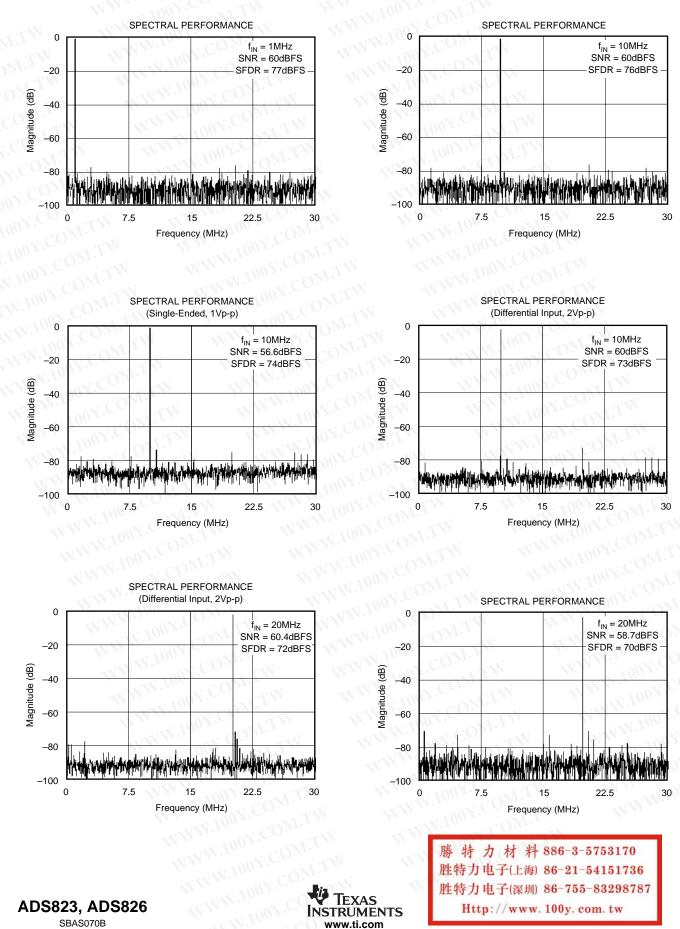
TIMING DIAGRAM



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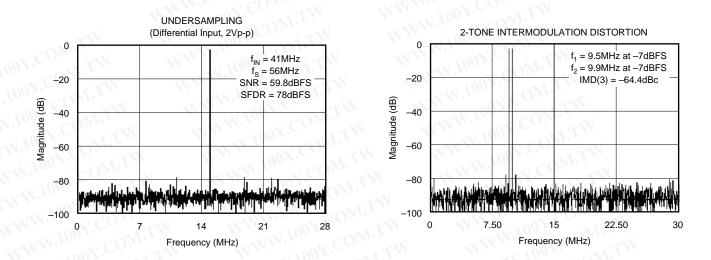
TYPICAL CHARACTERISTICS

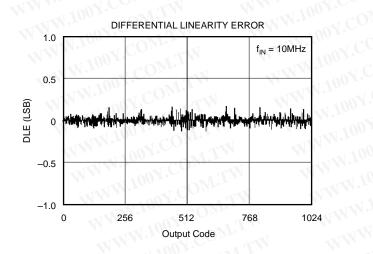
At T_A = full specified temperature range, V_S = +5V single-ended input range = 1.5V to 3.5V, sampling rate = 60MHz, external reference, unless otherwise noted.

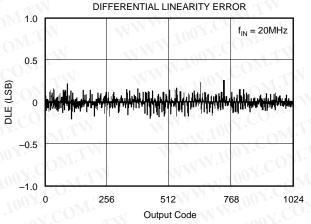


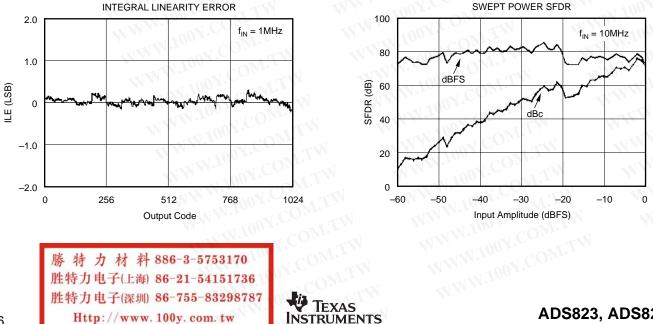
TYPICAL CHARACTERISTICS (Cont.)

At T_A = full specified temperature range, V_S = +5V single-ended input range = 1.5V to 3.5V, sampling rate = 60MHz, external reference, unless otherwise noted.









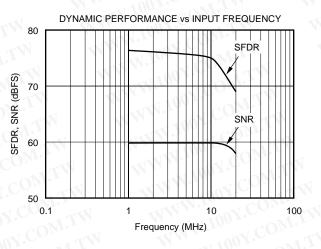
INSTRUMENTS

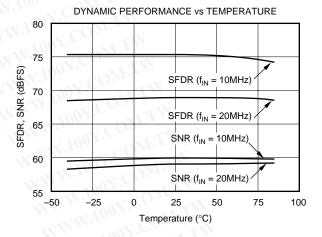
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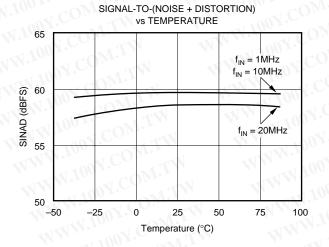


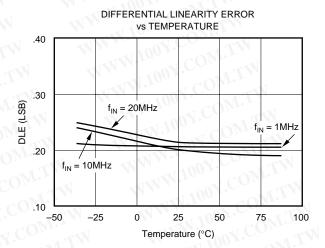
TYPICAL CHARACTERISTICS (Cont.)

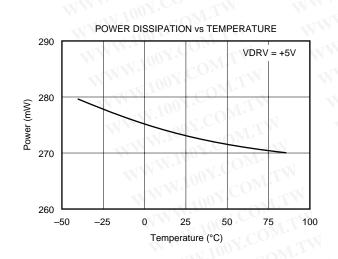
At T_A = full specified temperature range, V_S = +5V single-ended input range = 1.5V to 3.5V, sampling rate = 60MHz, external reference, unless otherwise noted.



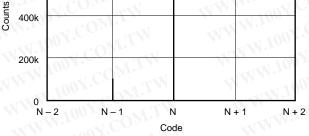








600k



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APPLICATION INFORMATION

THEORY OF OPERATION

The ADS823 and ADS826 are high-speed CMOS ADCs which employ a pipelined converter architecture consisting of 9 internal stages. Each stage feeds its data into the digital error correction logic ensuring excellent differential linearity and no missing codes at the 10-bit level. The output data becomes valid on the rising clock edge (see Timing Diagram on page 4). The pipeline architecture results in a data latency of 5 clock cycles.

The analog input of the ADS823 and the ADS826 is a differential track-and-hold, as shown in Figure 1. The differential topology along with tightly matched capacitors produce a high level of AC-performance while sampling at very high rates.

The ADS823 and ADS826 allows its analog inputs to be driven either single-ended or differentially. The typical configuration for the ADS823 and the ADS826 is for the singleended mode in which the input track-and-hold performs a single-ended to differential conversion of the analog input signal.

Both inputs (IN, \overline{IN}) require external biasing using a commonmode voltage that is typically at the mid-supply level (+V_S/2).

The following application discussion focuses on the singleended configuration. Typically, its implementation is easier to achieve and the rated specifications for the ADS823 and ADS826 are characterized using the single-ended mode of operation.

DRIVING THE ANALOG INPUT

The ADS823 and ADS826 achieve excellent AC performance either in the single-ended or differential mode of operation. The selection for the optimum interface configuration will depend

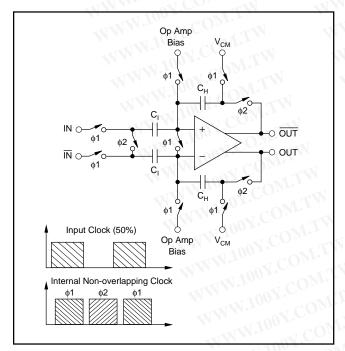


FIGURE 1. Simplified Circuit of Input Track-and-Hold with Timing Diagram.

on the individual application requirements and system structure. For example, communications applications often process a band of frequencies that does not include DC, whereas in imaging applications, the previously restored DC level must be maintained correctly up to the ADC. Features on the ADS823 and ADS826 like the input range select (RSEL pin) or the option for an external reference, provide the needed flexibility to accommodate a wide range of applications. In any case, the ADS823 and ADS826 should be configured such that the application objectives are met while observing the headroom requirements of the driving amplifier in order to yield the best overall performance.

INPUT CONFIGURATIONS

AC-Coupled, Single-Supply Interface

See Figure 2 for the typical circuit for an AC-coupled analog input configuration of the ADS823 and ADS826 while all components are powered from a single +5V supply.

With the RSEL pin connected HIGH, the full-scale input range is set to 2Vp-p. In this configuration, the top and bottom references (REFT, REFB) provide an output voltage of +3.5V and +1.5V, respectively. Two resistors ($2x 1.62k\Omega$) are used to create a common-mode voltage (V_{CM}) of approximately +2.5V to bias the inputs of the driving amplifier A1. Using the OPA680 on a single +5V supply, its ideal common-mode point is at +2.5V, which coincides with the recommended common-mode input level for the ADS823 and ADS826, thus obviating the need of a coupling capacitor between the amplifier and the converter. Even though the OPA680 has an AC gain of +2, the DC gain is only +1 due to the blocking capacitor at resistor R_G .

The addition of a small series resistor (R_s) between the output of the op amp and the input of the ADS823 and ADS826 will be beneficial in almost all interface configurations. This will decouple the op amp's output from the capacitive load and avoid gain peaking, which can result in increased noise. For best spurious and distortion performance, the resistor value should be kept below 100Ω . Furthermore, the series resistor in combination with the 10pF capacitor establishes a passive low-pass filter limiting the bandwidth for the wideband noise, thus helping improve the SNR performance.

AC-Coupled, Dual-Supply Interface

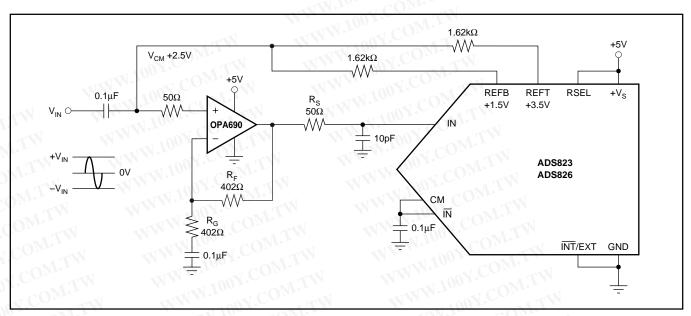
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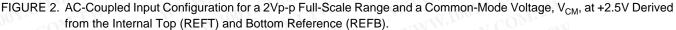
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See The circuit provided in Figure 3 for typical connections of the analog input in case the selected amplifier operates on dual supplies. This might be necessary to take full advantage of very low distortion operational amplifiers, like the OPA642. The advantage is that the driving amplifier can be operated with a ground referenced bipolar signal swing. This will keep the distortion performance at its lowest since the signal range stays within the linear region of the op amp and sufficient headroom to the supply rails can be maintained. By capacitively coupling the single-ended signal to the input of the ADS823 and ADS826, their common-mode requirements can easily be satisfied with two resistors connected between the top and bottom reference.







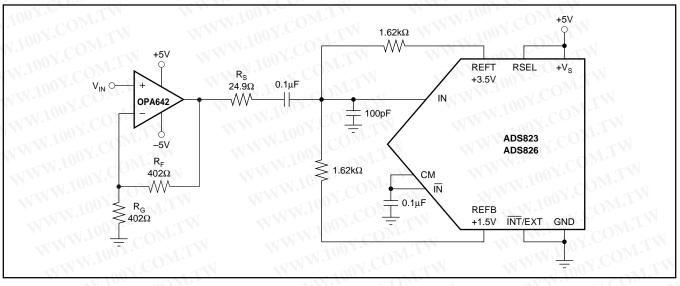


FIGURE 3. AC-Coupling the Dual-Supply Amplifier OPA642 to the ADS823 and ADS826 for a 2Vp-p Full-Scale Input Range.

For applications requiring the driving amplifier to provide a signal amplification, with a gain \geq 5, consider using decompensated voltage-feedback op amps, like the OPA686, or current-feedback op amps like the OPA6901.

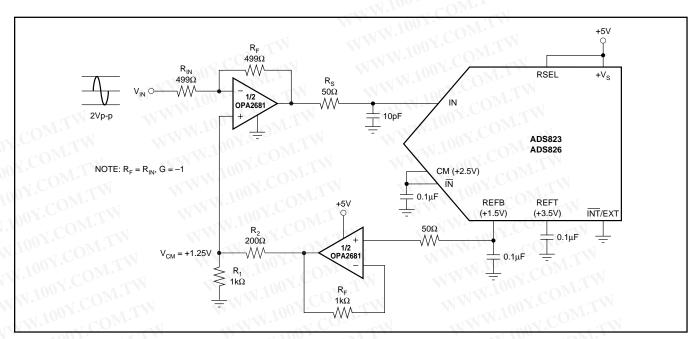
DC-Coupled with Level Shift

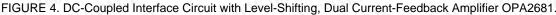
Several applications may require that the bandwidth of the signal path includes DC, in which case the signal has to be DC-coupled to the ADC. In order to accomplish this, the interface circuit has to provide a DC level shift to the analog input signal. The circuit of in Figure 4 employs a dual op amp, A1, to drive the input of the ADS823 and ADS826, and level shift the signal to be compatible with the selected input range. With the RSEL pin tied to the supply and the INT/EXT pin to ground, the ADS823 and ADS826 are configured for a 2Vp-p input range and uses the internal references. The complementary input (IN) may be appropriately biased using

the +2.5V common-mode voltage available at the CM pin. One half of amplifier A1 buffers the REFB pin and drives the voltage divider R₁, R₂. Due to the op amp's noise gain of +2V/V, assuming R_F = R_{IN}, the common-mode voltage (V_{CM}) has to be re-scaled to +1.25V. This results in the correct DC level of +2.5V for the signal input (IN). Any DC voltage differences between the IN and \overline{IN} inputs of the ADS823 and ADS826 effectively produce an offset, which can be corrected for by adjusting the resistor values of the divider, R₁ and R₂. The selection criteria for a suitable op amp should include the supply voltage, input bias current, output voltage swing, distortion, and noise specification. Note that in this example the overall signal phase is inverted. To re-establish the original signal polarity, it is always possible to interchange the IN and IN connections.

ADS823, ADS826 SBAS070B

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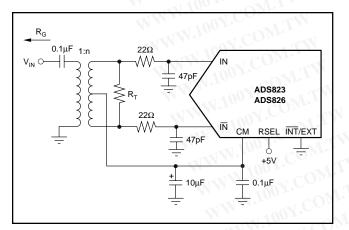


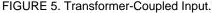


SINGLE-ENDED TO DIFFERENTIAL CONFIGURATION (Transformer Coupled)

If the application requires a signal conversion from a singleended source to feed the ADS823 and ADS826 differentially, a RF transformer might be a good solution. The selected transformer must have a center tap in order to apply the common-mode DC voltage necessary to bias the converter inputs. AC grounding the center tap will generate the differential signal swing across the secondary winding. Consider a step-up transformer to take advantage of a signal amplification without the introduction of another noise source. Furthermore, the reduced signal swing from the source may lead to an improved distortion performance.

The differential input configuration may provide a noticeable advantage of achieving good SFDR performance over a wide range of input frequencies. In this mode, both inputs of the ADS823 and ADS826 see matched impedances, and the differential signal swing can be reduced to half of the swing required for single-ended drive. Figure 5 shows the schematic for the suggested transformer-coupled interface circuit.





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The component values of the R-C low-pass may be optimized depending on the desired roll-off frequency. The resistor across the secondary side (R_T) should be calculated using the equation $R_T = n^2 \cdot R_G$ to match the source impedance (R_G) for good power transfer and VSWR.

REFERENCE OPERATION

Figure 6 depicts the simplified model of the internal reference circuit. The internal blocks are the bandgap voltage reference, the drivers for the top and bottom reference, and the

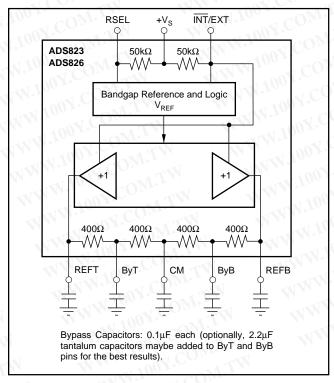


FIGURE 6. Equivalent Reference Circuit with Recommended Reference Bypassing.



10

resistive reference ladder. The bandgap reference circuit includes logic functions that allow to set the analog input swing of the ADS823 and ADS826 to either a 1Vp-p or 2Vp-p full-scale range simply by tying the RSEL pin to a LOW or HIGH potential, respectively. While operating the ADS823 and ADS826 in the external reference mode, the buffer amplifiers for the REFT and REFB are disconnected from the reference ladder.

As shown, the ADS823 and ADS826 have internal $50k\Omega$ pullup resistors at the range select pin (RSEL) and reference select pin (INT/EXT). Leaving those pins open configures the ADS823 for a 2Vp-p input range and external reference operation. Setting the ADS823 up for internal reference mode requires bringing the INT/EXT pin LOW.

The reference buffers can be utilized to supply up to 1mA (sink and source) to external circuitry. The resistor ladders of the ADS823 and ADS826 are divided into several segments and have two additional nodes, ByT and ByB, which are brought out for external bypassing only (See Figure 6). To ensure proper operation with any reference configurations, it is necessary to provide solid bypassing at all reference pins in order to keep the clock feedthrough to a minimum. All bypassing capacitors should be located as close to their respective pins as possible.

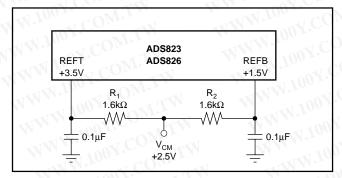


FIGURE 7. Alternative Circuit to Generate CM Voltage.

The common-mode voltage available at the CM pin may be used as a bias voltage to provide the appropriate offset for the driving circuitry. However, care must be taken not to appreciably load this node, which is not buffered and has a high impedance. An alternative way of generating a common-mode voltage is given in Figure 7. Here, two external precision resistors (tolerance 1% or better) are located between the top and bottom reference pins. The common-mode voltage, V_{CM} , will appear at the midpoint.

EXTERNAL REFERENCE OPERATION

For even more design flexibility, the internal reference can be disabled and an external reference voltage be used. The utilization of an external reference may be considered for applications requiring higher accuracy, improved temperature performance, or a wide adjustment range of the converter's full-scale range. Especially in multichannel applications, the use of a common external reference has the benefit of obtaining better matching of the full-scale range between converters.

The external references can vary as long as the value of the external top reference REFT_{EXT} stays within the range of (V_S – 1.25V) and (REFB + 0.8V), and the external bottom reference REFB_{EXT} stays within 1.25V and (REFT – 0.8V), as shown in Figure 8.

DIGITAL INPUTS AND OUTPUTS

Clock Input Requirements

Clock jitter is critical to the SNR performance of high-speed, high-resolution ADCs. Clock jitter leads to aperture jitter (t_A), which adds noise to the signal being converted. The ADS823 and ADS826 samples the input signal on the rising edge of the CLK input. Therefore, this edge should have the lowest possible jitter. The jitter noise contribution to total SNR is given by

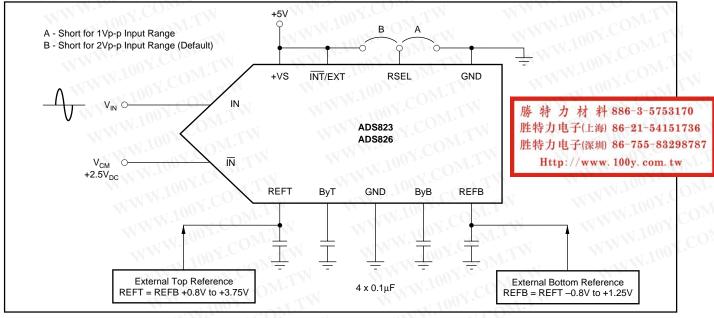


FIGURE 8. Configuration Example for External Reference Operation.



the following equation. If this value is near your system requirements, input clock jitter must be reduced.

Jitter SNR =
$$20 \log \frac{1}{2\pi f_{IN} t_A}$$
 rms signal to rms noise

where: f_{IN} is input signal frequency t_A is rms clock jitter

Particularly in undersampling applications, special consideration should be given to clock jitter. The clock input should be treated as an analog input in order to achieve the highest level of performance. Any overshoot or undershoot of the clock signal may cause degradation of the performance. When digitizing at high sampling rates, the clock should have 50% duty cycle ($t_H = t_L$), along with fast rise and fall times of 2ns or less. To estimate the typical performance deviation for clock duty cycles in the range of 50% ±7.5%, refer to Figure 9. The clock input of the ADS826 can be driven with either 3V or 5V logic levels. Using low-voltage logic (3V) may lead to improved AC performance of the converters.

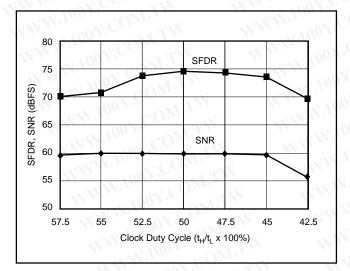
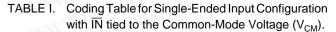


FIGURE 9. ADS823 and ADS826 Duty Cycle Sensitivity.

Digital Outputs

The output data format of the ADS823 and ADS826 is in positive Straight Offset Binary code as shown in Tables I and II. This format can easily be converted into the Binary Two's Complement code by inverting the MSB.

SINGLE-ENDED INPUT (IN = CMV)	STRAIGHT OFFSET BINARY (SOB)
+FS –1LSB (IN = REFT)	111111111
+1/2 Full-Scale	110000000
Bipolar Zero (IN = V _{CM})	100000000
-1/2 Full-Scale	010000000
–FS (IN = REFB)	000000000



DIFFERENTIAL INPUT	STRAIGHT OFFSET BINARY (SOB)
+FS –1LSB (IN = +3V, IN = +2V)	111111111
+1/2 Full-Scale	110000000
Bipolar Zero (IN = \overline{IN} = V _{CM})	100000000
-1/2 Full-Scale	010000000
$-FS (IN = +2V, \overline{IN} = +3V)$	000000000

TABLE II. Coding Table for Differential Input Configuration and 2Vp-p Full-Scale Range.

It is recommended to keep the capacitive loading on the data lines as low as possible (\leq 15pF). Higher capacitive loading will cause larger dynamic currents as the digital outputs are changing. Those high current surges can feed back to the analog portion of the ADS823 and ADS826 and affect performance. If necessary, external buffers or latches close to the converter's output pins may be used to minimize the capacitive loading. They also provide the added benefit of isolating the ADS823 and ADS826 from any digital noise activities on the bus coupling back high frequency noise.

Digital Output Driver (VDRV)

The ADS823 and ADS826 feature a dedicated supply pin for the output logic drivers, VDRV, which is not internally connected to the other supply pins. Setting the voltage at VDRV to +5V or +3V, the ADS823 and ADS826 produce corresponding logic levels and can directly interface to the selected logic family. The output stages are designed to supply sufficient current to drive a variety of logic families. However, it is recommended to use the ADS823 and ADS826 with +3V logic supply. This will lower the power dissipation in the output stages due to the lower output swing and reduce current glitches on the supply line which may affect the ACperformance of the converter. In some applications, it might be advantageous to decouple the VDRV pin with additional capacitors or a pi-filter.

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GROUNDING AND DECOUPLING

Proper grounding and bypassing, short lead length, and the use of ground planes are particularly important for highfrequency designs. Multilaver PC boards are recommended for best performance since they offer distinct advantages like minimizing ground impedance, separation of signal layers by ground layers, etc. The ADS823 and ADS826 should be treated as analog components. Whenever possible, the supply pins should be powered by the analog supply. This will ensure the most consistent results, since digital supply lines often carry high levels of noise which otherwise would be coupled into the converter and degrade the achievable performance. All ground connections on the ADS823 and ADS826 are internally joined together, obviating the design of split ground planes. The ground pins (1, 16, 26) should directly connect to an analog ground plane which covers the PC board area around the converter. While designing the layout, it is important to keep the analog signal traces separated from any digital lines to prevent noise coupling onto the analog signal path. Due to the high sampling rate, the ADS823 and ADS826 generate high frequency current transients and noise (clock feedthrough) that are fed back into the supply and reference lines. This requires that all supply and reference pins are sufficiently bypassed. Figure 10

shows the recommended decoupling scheme for the ADS823 and ADS826. In most cases 0.1μ F ceramic chip capacitors at each pin are adequate to keep the impedance low over a wide frequency range. Their effectiveness largely depends on the proximity to the individual supply pin. Therefore, they should be located as close to the supply pins as possible. In addition, a larger bipolar capacitor (1μ F to 22 μ F) should be placed on the PC board in proximity of the converter circuit.

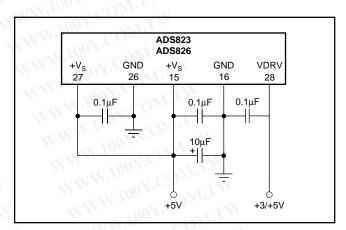
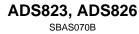


FIGURE 10. Recommended Bypassing for the Supply Pins.

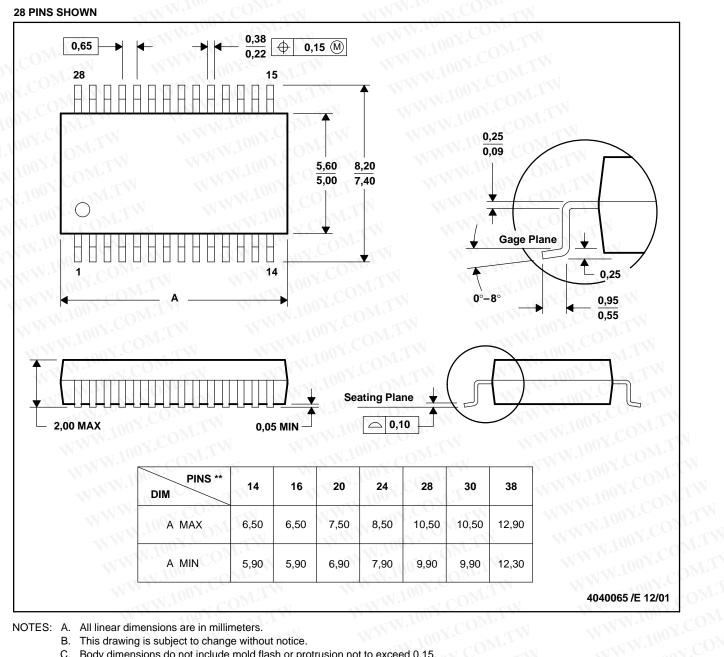
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DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

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TEXAS

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins F	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
ADS823E	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ADS823E/1K	ACTIVE	SSOP	DB	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ADS823E/1KG4	ACTIVE	SSOP	DB	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ADS823EG4	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ADS826E	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ADS826E/1K	ACTIVE	SSOP	DB	28	1000 <	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ADS826E/1KG4	ACTIVE	SSOP	DB	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ADS826EG4	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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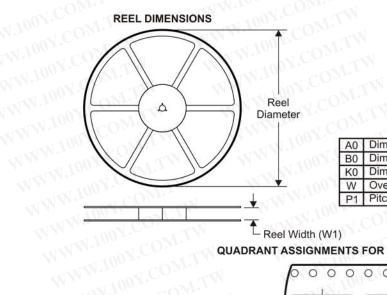
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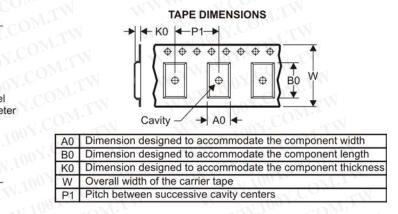
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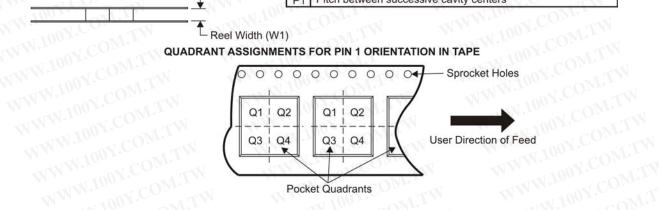
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Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS823E/1K	SSOP	DB	28	1000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
ADS826E/1K	SSOP	DB	28	1000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1

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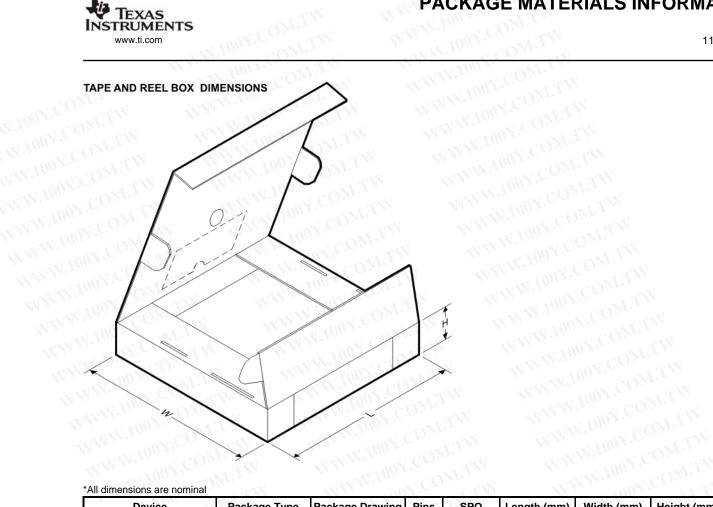
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	ackage Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS823E/1K	SSOP	DB	28	1000	346.0	346.0	33.0
DS826E/1K	SSOP	DB	28	1000	346.0	346.0	33.0

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